

# ECE606: Solid State Devices

## Lecture 16

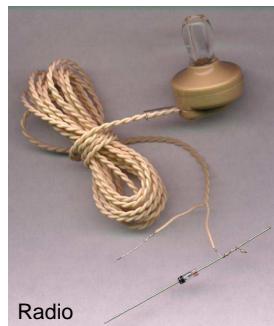
### p-n diode AC Response

Gerhard Klimeck  
[gekco@purdue.edu](mailto:gekco@purdue.edu)

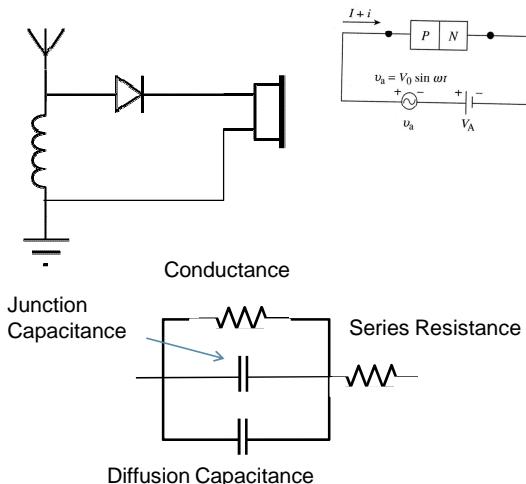
## Topic Map

	Equilibrium	DC	Small signal	Large Signal	Circuits
Diode					
Schottky				Diode in Non-Equilibrium (External DC+AC voltage applied)	
BJT/HBT					
MOSFET					

### Motivation



[www.sci-toy.com](http://www.sci-toy.com)



- 1) Conductance and series resistance
- 2) Majority carrier junction capacitance
- 3) Minority carrier diffusion capacitance
- 4) Conclusion

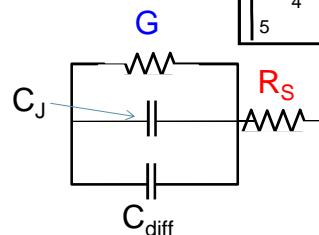
Ref. SDF, Chapter 7

## Forward Bias Conductance

$$I = I_o \left( e^{q(V_A - R_S I) \beta / m} - 1 \right)$$

$m = RG$  (2), diff (1), Ambipolar (2)

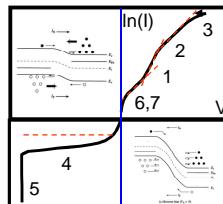
$$\ln \frac{I + I_o}{I_0} = q(V_A - R_S I) \frac{\beta}{m}$$



$$\frac{m}{q\beta(I + I_o)} = \frac{dV_A}{dI} - R_S$$

$$\frac{1}{g_{FB}} = R_S + \frac{m}{q\beta(I + I_0)}$$

Forward Bias Conductance



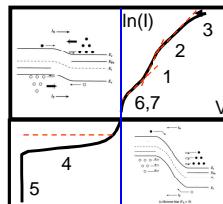
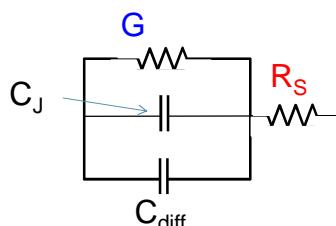
## Reverse Bias Conductance

$$I = I_o \left( e^{q(V_A - R_S I) \beta / m} - 1 \right) - \frac{qn_i}{2\tau} B_0 \sqrt{V_{bi} - V_A}$$

$$\approx -I_0 - \frac{qn_i}{2\tau} B_0 \sqrt{V_{bi} - V_A}$$

$$\frac{1}{g_{RB}} = \frac{qn_i B_0}{2\tau \sqrt{V_{bi} - V_A}}$$

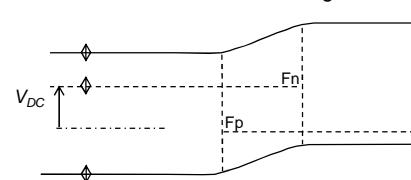
Reverse Bias Conductance



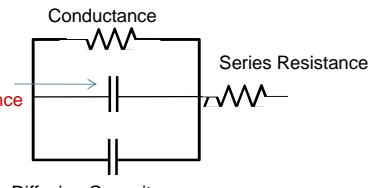
- 1) Conductance and series resistance
- 2) Majority carrier junction capacitance**
- 3) Minority carrier diffusion capacitance
- 4) Conclusion

## Junction Capacitance

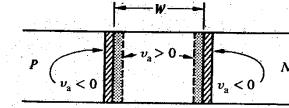
Forward biased diode + AC signal



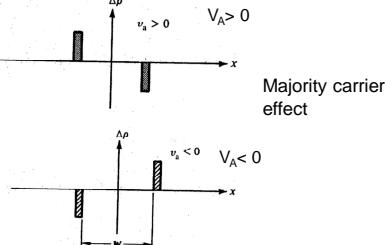
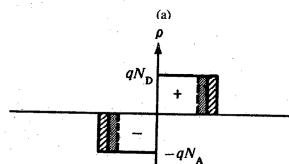
Junction  
Capacitance

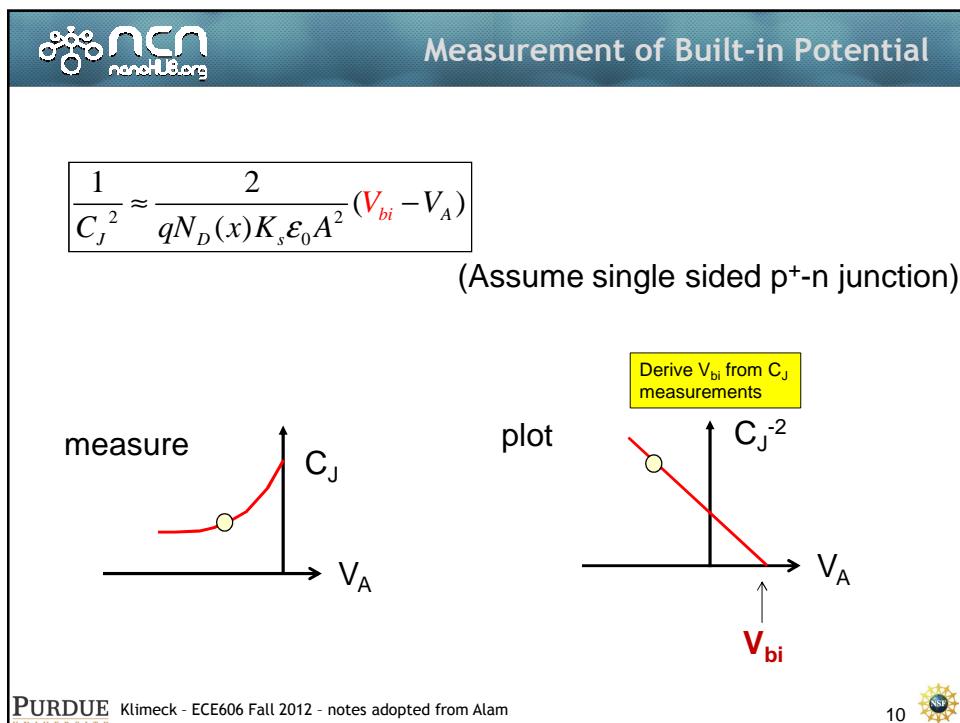
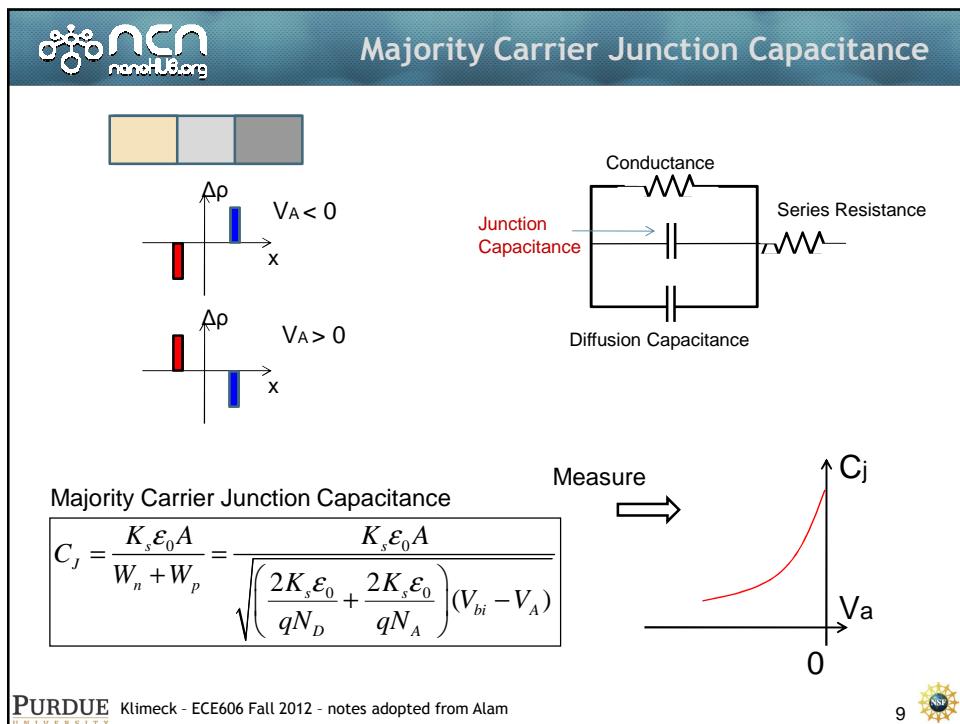


Depletion width modulation



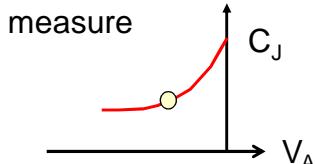
Charge modulation





$$\frac{1}{C_J^2} \approx \frac{2}{qN_D(x)K_s\epsilon_0 A^2} (V_{bi} - V_A)$$

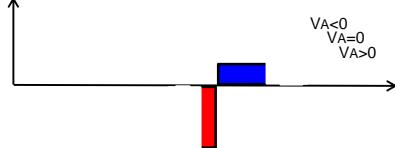
measure



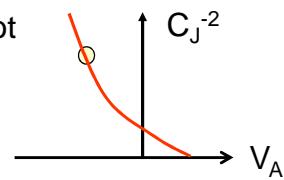
$$N_D(x) = \frac{2}{qK_s\epsilon_0 A^2} \frac{1}{d(1/C_J^2)/dV_A}$$

Measure doping concentration  
as a function of position

Charge

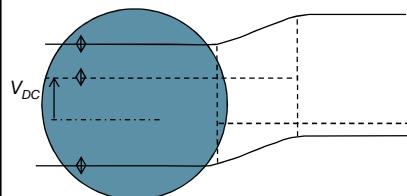


plot



$$J_n = qn\mu_N E + q\mathcal{D}_N \nabla n$$

$$\frac{dn}{dt} = \frac{1}{q} \frac{dJ_n}{dx} - \mathcal{R}_n + \mathcal{X}_n$$



$$\frac{d(\Delta n)}{dt} = \frac{1}{q} \frac{d(qn\mu_N \mathcal{E})}{dx} = N_D \mu_N \frac{d\mathcal{E}}{dx}$$

$$\frac{d\mathcal{E}}{dx} = \frac{q}{k_s \epsilon_0} (\mathcal{X}_{N\text{-side}} - n_0 - \Delta n + N_D - \mathcal{X}_A)$$

How long does it take for the  
signal to cross the junction?

$$\tau_d = \frac{K_s \epsilon_0}{\sigma} \approx 0.1 \text{ ps}$$

Very fast

$$\frac{d(\Delta n)}{dt} = -\frac{qN_D \mu_N}{k_s \epsilon_0} \Delta n = -\frac{\sigma_0 \Delta n}{k_s \epsilon_0}$$

$$\Delta n(t) = n_0 e^{-\frac{\sigma_0 t}{k_s \epsilon_0}} = n_0 e^{-\frac{t}{\tau_d}}$$

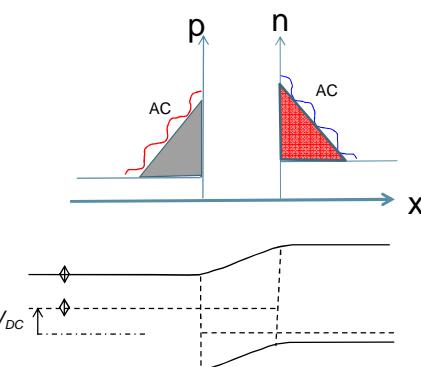
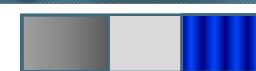
- 1) Conductance and series resistance
- 2) Majority carrier junction capacitance
- 3) Minority carrier diffusion capacitance**
- 4) Conclusion

Minority Carrier side

$$\mathbf{J}_N = qn \mathcal{E} + qD_N \frac{dn}{dx}$$

$$\frac{\partial n}{\partial t} = \frac{1}{q} \frac{dJ_n}{dx} - r_N + g_N$$

$$\frac{\partial (n_0 + \Delta n_{dc} + \Delta n_{ac} e^{j\omega t})}{\partial t} = D_N \frac{d^2 (n_0 + \Delta n_{dc} + \Delta n_{ac} e^{j\omega t})}{dx^2} - \frac{\Delta n_{dc} + \Delta n_{ac} e^{j\omega t}}{\tau_n}$$



$$\frac{\partial(n_0 + \Delta n_{dc} + \Delta n_{ac} e^{j\omega t})}{\partial t} = D_N \frac{d^2(n_0 + \Delta n_{dc} + \Delta n_{ac} e^{j\omega t})}{dx^2} - \frac{\Delta n_{dc} + \Delta n_{ac} e^{j\omega t}}{\tau_n}$$

$$j\omega \Delta n_{ac} e^{j\omega t} = D_N \frac{d^2 \Delta n_{dc}}{dx^2} + e^{j\omega t} \frac{d^2 \Delta n_{ac}}{dx^2} - \frac{\Delta n_{dc}}{\tau_n} - e^{j\omega t} \frac{\Delta n_{ac}}{\tau_n}$$

DC:  $0 = D_N \frac{d^2 \Delta n_{dc}}{dx^2} - \frac{\Delta n_{dc}}{\tau_n} \Rightarrow \Delta n_{dc} = A e^{-\frac{x}{L_n}} + B e^{+\frac{x}{L_n}}$

AC:  $0 = D_N \frac{d^2 \Delta n_{ac}}{dx^2} - (j\omega \tau_n + 1) \frac{\Delta n_{ac}}{\tau_n} \Rightarrow \Delta n_{ac} = C e^{-\frac{x}{L_n^*}} + D e^{+\frac{x}{L_n^*}} \rightarrow C e^{-\frac{x}{L_n^*}}$

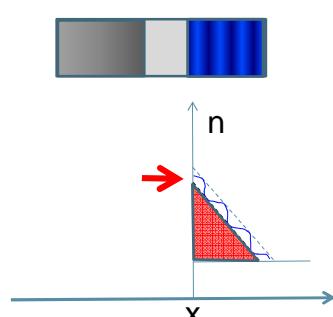
$$L_n^* = \sqrt{D_n \tau_n / (1 + j\omega \tau_n)} \quad \tau_n^* = \tau_n / (1 + j\omega \tau_n)$$

$$\Delta n_{dc}(x=0) = \frac{n_i^2}{N_A} \left( e^{\frac{qV_{dc}}{kT}} - 1 \right)$$

$$(\Delta n_{dc} + \Delta n_{ac} e^{j\omega t}) = \frac{n_i^2}{N_A + \Delta p_{ac} e^{j\omega t}} \left( e^{\frac{q(V_{dc} + V_{ac} e^{j\omega t})}{kT}} - 1 \right)$$

$$(\Delta n_{dc} + \Delta n_{ac} e^{j\omega t}) \approx \frac{n_i^2}{N_A} \left( e^{\frac{qV_{dc}}{kT}} e^{\frac{qV_{ac} e^{j\omega t}}{kT}} - 1 \right)$$

$$\approx \frac{n_i^2}{N_A} \left\{ e^{\frac{qV_{dc}}{kT}} \left( 1 + \frac{qV_{ac} e^{j\omega t}}{kT} \right) - 1 \right\}$$



$$\Delta n_{ac}(x=0) = \frac{qV_{ac}}{kT} \frac{n_i^2}{N_A} e^{\frac{qV_{dc}}{kT}} = C$$

$$\Delta n_{ac}(x=0) = \frac{qV_{ac}}{kT} \frac{n_i^2}{N_A} e^{\frac{qV_{dc}}{kT}} = C$$

$$\Delta n_{ac}(x) = Ce^{-\frac{x}{L_n^*}} + De^{+\frac{x}{L_n^*}} \rightarrow Ce^{-\frac{x}{L_n^*}}$$

Finally...

$$J_{ac} = -qD_n \frac{d\Delta n_{ac}}{dx} \Big|_{x=0} = \frac{qD_n}{L_n^*} \frac{qV_{ac}}{kT} \frac{n_i^2}{N_A} e^{\frac{qV_{dc}}{kT}}$$

AC Current

$$Y_{ac} = \frac{J_{ac}}{V_{ac}} = \frac{q^2 D_n}{L_n^* kT} \frac{n_i^2}{N_A} e^{\frac{qV_{dc}}{kT}} \equiv G_0 \sqrt{1 + j\omega\tau_n}$$

AC Impedance

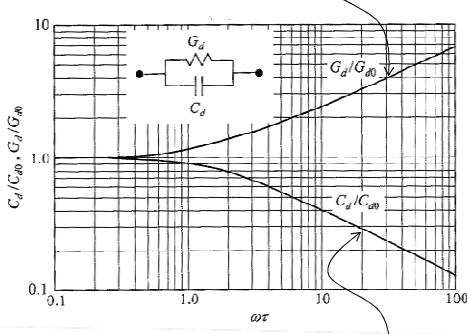
$$G_D \propto \sqrt{\omega}$$

$$Y_{ac} = G_D + j\omega C_D \equiv G_0 \sqrt{1 + j\omega\tau_n}$$

Separate in real & imaginary parts ...

$$G_D = \frac{G_0}{\sqrt{2}} \left[ \sqrt{1 + \omega^2 \tau_n^2} + 1 \right]^{1/2}$$

$$\omega C_D = \frac{G_0}{\sqrt{2}} \left[ \sqrt{1 + \omega^2 \tau_n^2} - 1 \right]^{1/2}$$



Product of  $G_D$  and  $C_D$   
frequency-independent

$$C_D \propto 1/\sqrt{\omega}$$

- 1) Small signal response relevant for many analog applications.
- 2) Small signal parameters always refer to the DC operating conditions, as such the parameter changes with bias condition.
- 3) Important to distinguish between majority and minority carrier capacitance. Their relative importance depends on specific applications.

## ECE606: Solid State Devices

### p-n diode

### Large Signal Response

Gerhard Klimeck  
[gekco@purdue.edu](mailto:gekco@purdue.edu)

**nanoHUB.org**

Digital Signals: switch on and off

**Topic Map**

	Equilibrium	DC	Small signal	<b>Large Signal</b>	Circuits
<b>Diode</b>				◆	
Schottky					
BJT/HBT					
MOSFET					



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**Outline**

- 1) Large signal response and charge control model
- 2) Turn-off characteristics
- 3) Turn-on characteristics
- 4) Other applications
- 5) Conclusion

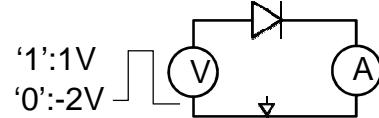
Ref. SDF, Chapter 8

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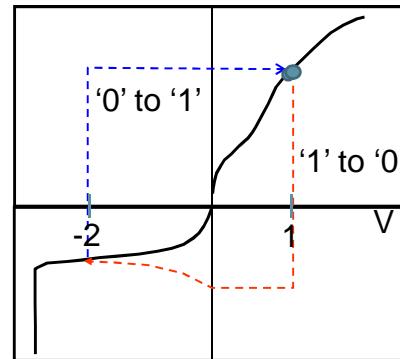
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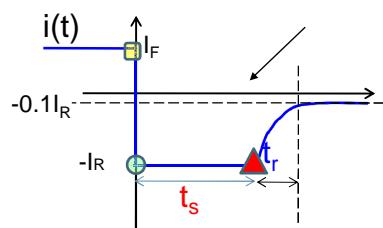
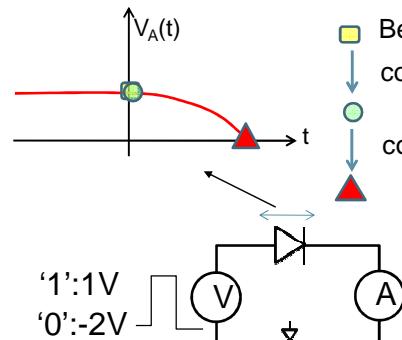
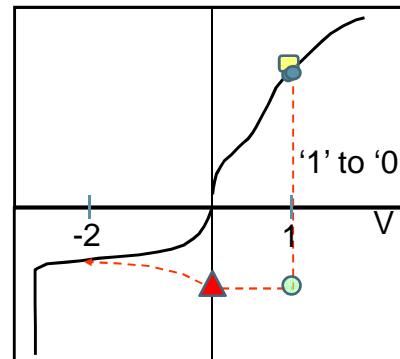
— :If transition is slow,  
every point is in  
quasi-equilibrium  
→ treat them like DC

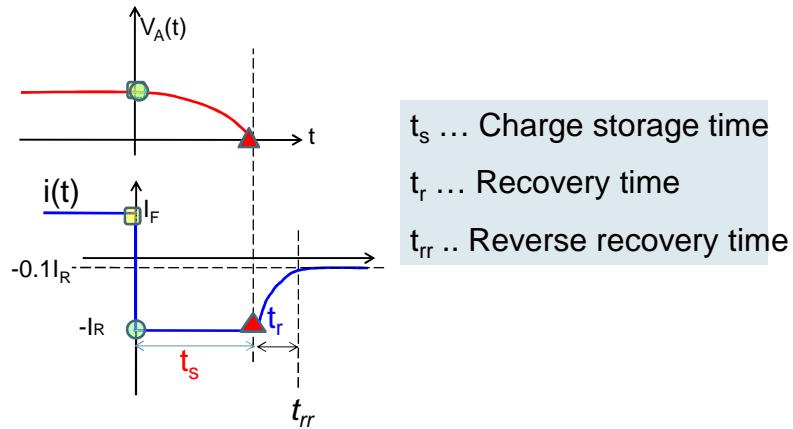


---:If transition is very  
fast

 $\ln(I)$ 


Before transition occur  
constant voltage, current change from  $I_F$  to  $I_R$   
constant current, voltage change form 1V to 0V


 $\ln(I)$ 




Full analytical solution impossible for large signal....

$$\nabla \bullet D = q(p - n + N_D^+ - N_A^-)$$

$$\frac{\partial n}{\partial t} = \frac{1}{q} \nabla \bullet \mathbf{J}_N - r_N + g_N$$

$$\mathbf{J}_N = qn\mu_N \mathcal{E} + qD_N \nabla n$$

$$\frac{\partial p}{\partial t} = \frac{1}{q} \nabla \bullet \mathbf{J}_P - r_P + g_P$$

$$\mathbf{J}_P = qp\mu_P \mathcal{E} - qD_P \nabla p$$

$$\frac{\partial Q_n}{\partial t} = i_{n,diff} - \frac{Q_n}{\tau_n}$$

$$\frac{\partial Q_p}{\partial t} = i_{p,diff} - \frac{Q_p}{\tau_n}$$

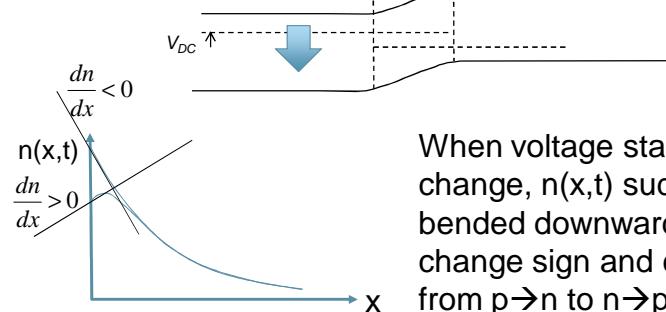
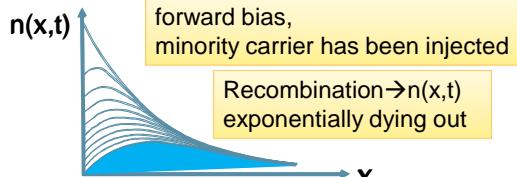
**Charge control equations:**  
Approximation when you have  
large transient response



## How Does Current Flip Without Voltage Flipping?

Where did the charge go?

1. Back to the left-hand side
2. Recombine with the trap and the majority carrier



When voltage start to change,  $n(x,t)$  suddenly bended downwards,  $dn/dx$  change sign and current flip from  $p \rightarrow n$  to  $n \rightarrow p$



## Large Signal Charge Control Model

$$\frac{\partial n}{\partial t} = \frac{1}{q} \frac{dJ_n}{dx} - r_N + g_N$$

$$\downarrow$$

$$\frac{\partial(\Delta n)}{\partial t} = D_N \frac{d^2(\Delta n)}{dx^2} - \frac{\Delta n}{\tau_n}$$

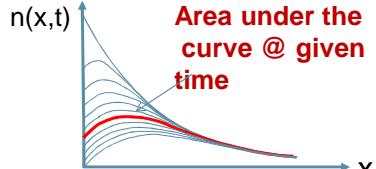
minority carrier

$$\mathbf{J}_N = qn\mu_N \mathcal{E} + qD_N \frac{dn}{dx}$$

$$\frac{\partial(\Delta n)}{\partial t} = D_N \frac{d^2(\Delta n)}{dx^2} - \frac{\Delta n}{\tau_n}$$

$\downarrow x(qA), \text{ integrate}$

$$\int_0^{W_p} \frac{\partial(qA\Delta n)}{\partial t} dx = \int_0^{W_p} D_N \frac{d}{dx} \frac{d(qA\Delta n)}{dx} dx - \int_0^{W_p} \frac{qA\Delta n}{\tau_n} dx$$



Current going out

Current coming in

$$\frac{\partial Q}{\partial t} = D_N \left. \frac{d(qA\Delta n)}{dx} \right|_{x=W_p} - D_N \left. \frac{d(qA\Delta n)}{dx} \right|_{x=0} - \frac{Q}{\tau_n}$$

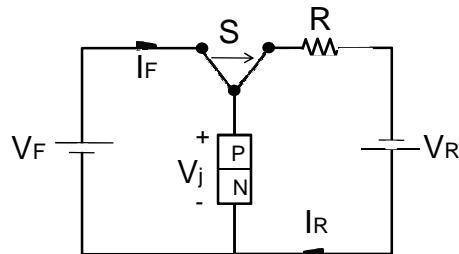
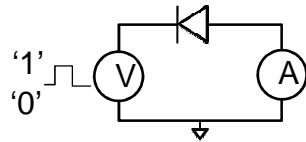
$$Q \equiv \int_0^{W_p} (qA\Delta n) dx$$

Recombination

$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n} \quad (\text{Total charge that is building in}) = \\ (\text{net electrons flowing in}) - (\text{recombination})$$

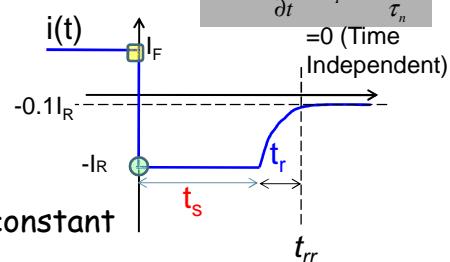
- 1) Large signal response and charge control model
- 2) Turn-off characteristics**
- 3) Turn-on characteristics
- 4) Other applications
- 5) Conclusion

## Turn-off Characteristics: Determine ( $t_s$ )



$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$t < 0 \quad \frac{\partial Q}{\partial t} = I_F - \frac{Q(0^-)}{\tau_n}$$



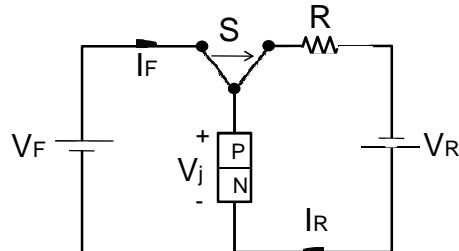
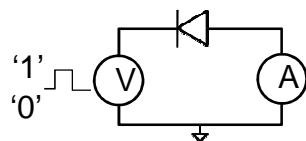
Why does the current remain constant even with  $t > 0$ ?

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## Boundary Condition



$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$t < 0 \quad \frac{\partial Q}{\partial t} = I_F - \frac{Q(0^-)}{\tau_n} = 0$$

$$Q(0^-) = I_F \tau_n = Q(0^+)$$

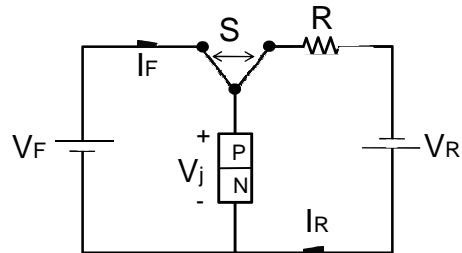
Note. For a capacitor, voltage can not change instantly.  
So charge can not change instantly ....

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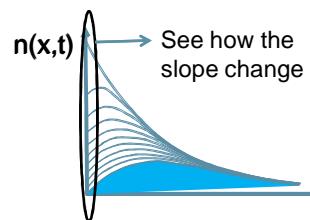
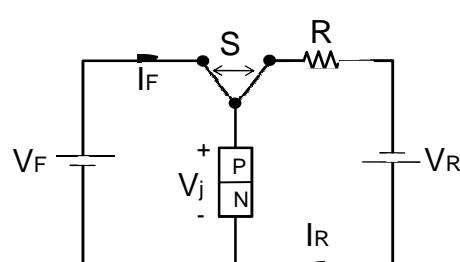


## Turn-off **Current** Transient



Since  $V_j$  can't be larger than the band gap, which is smaller than  $V_R$ , the diode will be forced to supply the negative current  $I_R$

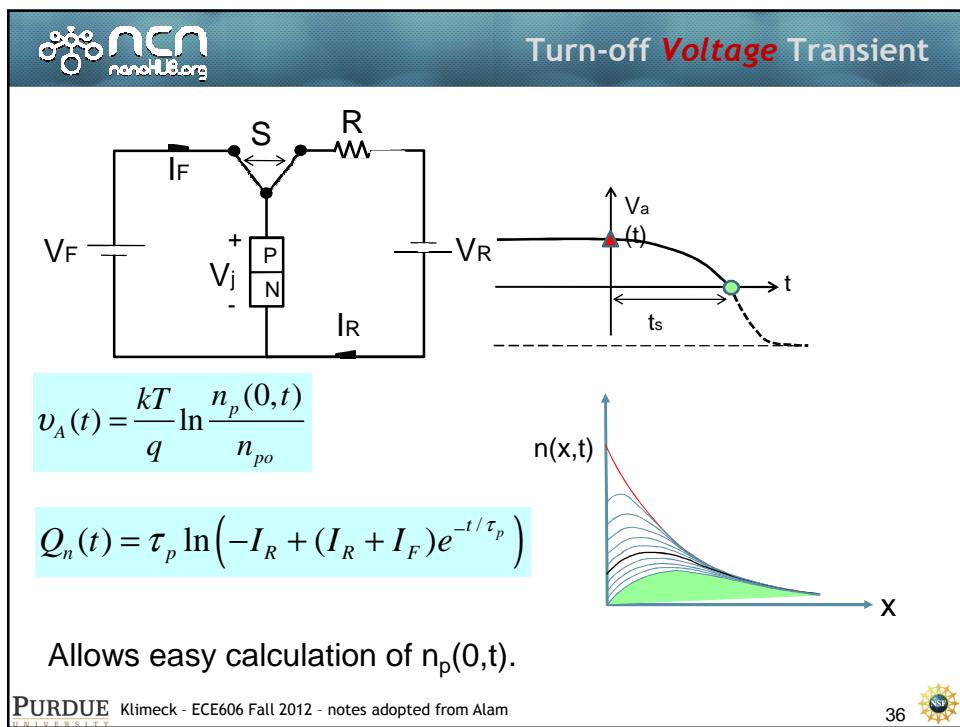
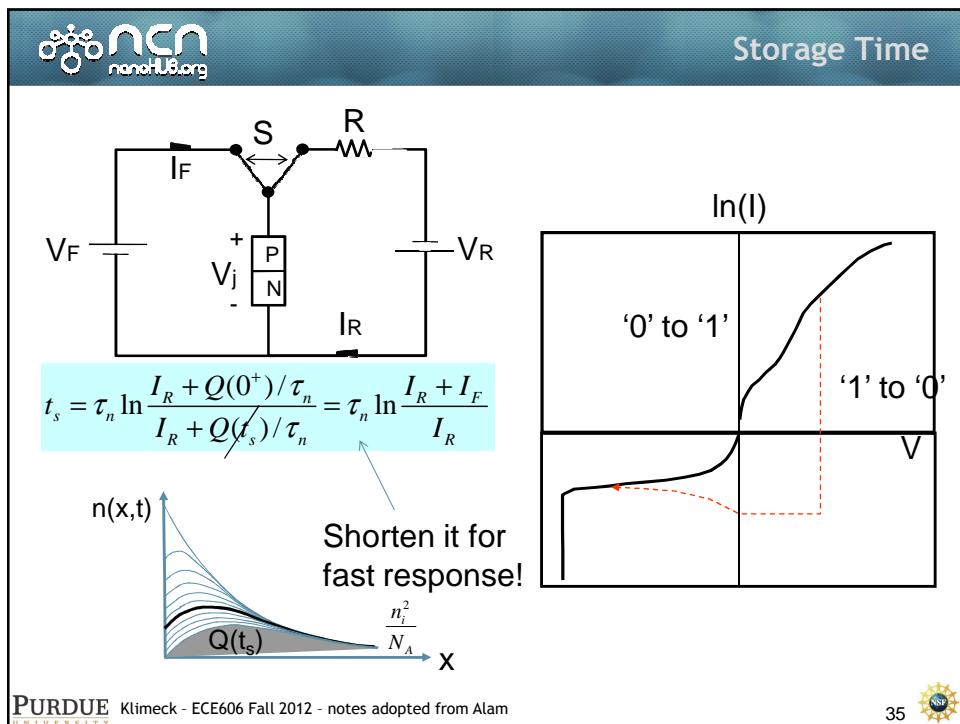
## Turn-off **Current** Transient



Approximately constant!

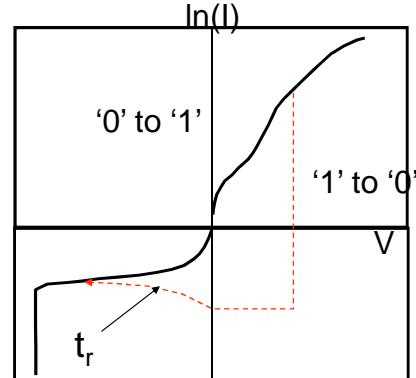
$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n} \quad \longrightarrow \quad t > 0 \quad \frac{\partial Q}{\partial t} = -I_R - \frac{Q}{\tau_n}$$

$$t_s = \tau_n \ln \frac{I_R + Q(0^+)/\tau_n}{I_R + Q(t_s)/\tau_n} \quad \longleftarrow \quad \int_{Q(0^+)}^{Q(t_s)} \frac{dQ}{I_R + \frac{Q}{\tau_n}} = \int_0^{t_s} dt$$



## Recovery Time

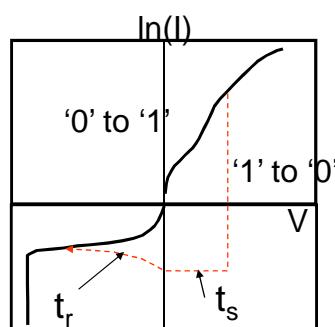
$$erf \sqrt{\frac{t_r}{\tau_p}} + \frac{e^{-\frac{t_r}{\tau_p}}}{\sqrt{\pi \frac{t_r}{\tau_p}}} = 1 + 0.1 \frac{I_F}{I_R}$$



Useful formula ...

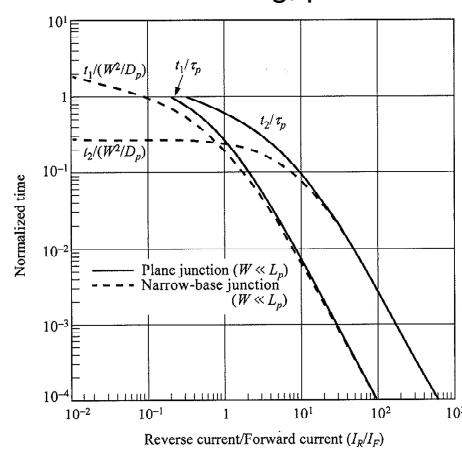
$$erf(\sqrt{x}) = \left[ 1 - e^{-x \frac{1.27 + 0.15x}{1 + 0.15x}} \right]^{0.5}$$

## Recovery Time

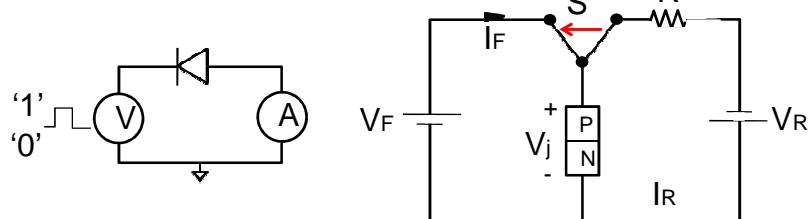


$$t_{rr} = t_r + t_f \approx \begin{cases} \frac{W_p^2}{2D_n} \left( \frac{I_R}{I_F} \right)^{-2} & (W_p \ll L_n) \\ \frac{\tau_p}{2} \left( \frac{I_R}{I_F} \right)^{-2} & (W_p \gg L_n) \end{cases}$$

Ref. Sze/Ng, p. 117



- 1) Large signal response and charge control model
- 2) Turn-off characteristics
- 3) Turn-on characteristics**
- 4) Other applications
- 5) Conclusion

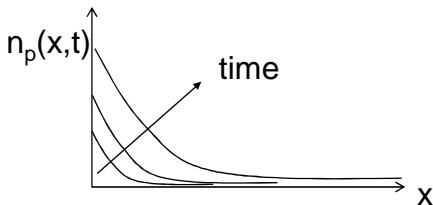
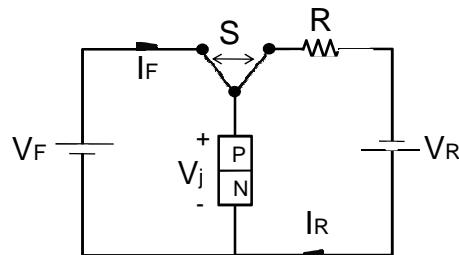


$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$t \rightarrow \infty \quad \frac{\partial Q}{\partial t} = I_F - \frac{Q(t=\infty)}{\tau_n}$$

$$Q(t=\infty) = I_F \tau_n$$

## Turn-on Characteristics



$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$t > 0 \quad \frac{\partial Q}{\partial t} = I_F - \frac{Q}{\tau_n}$$

$$Q(t) = Q(t \rightarrow \infty) \left( 1 - e^{-\frac{t}{\tau_n}} \right) = I_F \tau_n \left( 1 - e^{-\frac{t}{\tau_n}} \right)$$

Check:  
 $Q(t=0)=0$   
 $Q(t \rightarrow \infty)=I_F \tau_n$

## Outline

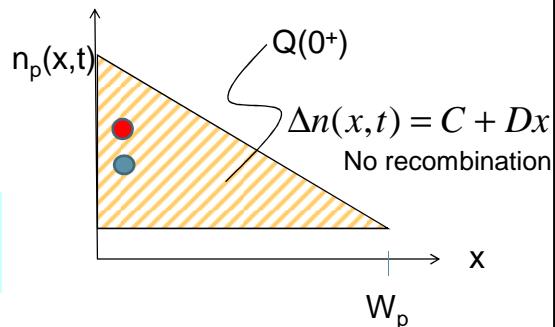
- 1) large signal response and charge control model
- 2) turn-off characteristics
- 3) turn-on characteristics
- 4) other applications**
- 5) conclusion

## Diffusion Time

Electrons get scattered to the other side, the average time is...

$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$\frac{Q(0^+) - Q(t=\infty)}{\tau_{diff}} = i_{diff}$$



$$\tau_{diff} = \frac{Q(0^+)}{i_{diff}} = \frac{q \left[ \frac{\Delta n_p(0)}{2} \right] W_p}{q D_n \frac{\Delta n_p(0)}{W_p}} = \frac{W_p^2}{2 D_n} \sim \frac{1}{2} \times \frac{W_p}{(D_n / W_p)}$$

Only half of them goes to the right

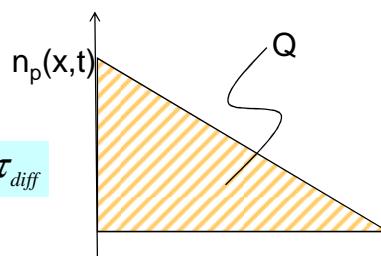
Diffusion velocity



## Steady State Diode Current

$$\frac{\partial Q}{\partial t} = i_{diff} - \frac{Q}{\tau_n}$$

$$i_{diff} = \frac{Q}{\tau_{diff}}$$



$$i_{diff} = \frac{Q}{\tau_{diff}} = \frac{q \times \frac{1}{2} \frac{n_i^2}{N_A} (e^{qV_A\beta} - 1) \times W_p}{\frac{W_p^2}{2 D_n}} = q \frac{D_n}{W_p} \frac{n_i^2}{N_A} (e^{qV_A\beta} - 1)$$

Exact Expression!



Large signal response of devices of great importance for digital applications.

Analytical solution of partial differential equation often difficult (if not impossible), therefore approximate methods like Charge-control approximation often help simplify the solution and still provide a great deal of insight into the dynamics of switching operation.

Be careful in using the boundary condition which is often dictated by external circuit conditions.